

AUTOMOTIVE CURRENT TRANSDUCER FLUXGATE TECHNOLOGY

CAB-SF 1500-000, CAB-SF 1500-001, CAB-SF 1500-004, CAB-SF 1500-005, CAB-SF 1500-006, CAB-SF 1500-009, CAB-SF 1500-009, CAB-SF 1500-001, CAB 1500-001, CAB 1500-005





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Introduction

The CAB transducer family is specially designed for the DC current measurement of the battery packs in electric and hybrid vehicles. The CAB 1500 Family transducer is equipped with electronic mechanisms and software that guarantee a level of reliability that is required by the security concepts of battery management systems.

Features

- Fluxgate transducer technology
- · Busbar mounting or panel mounting
- Unipolar +12 V battery power supply
- Output signal: High speed CAN (500 kpbs).

	CAN Resistor	Casing	Other
	Termination	Version	Comments
CAB-SF 1500-000	4800 Ω	Bus bar	
CAB-SF 1500-001	4800 Ω	Panel mounting	
CAB-SF 1500-004	4800 Ω	Bus bar	Inverted I_P sig
CAB-SF 1500-005	4800 Ω	Bus bar	CAN ID 0x10
CAB-SF 1500-006	120 Ω	Bus bar	
CAB-SF 1500-008	4800 Ω	Bus bar	CAN ID 0x4C2
CAB-SF 1500-009	4800 Ω	Bus bar	
CAB-SF 1500-011	120 Ω	Panel mounting	
CAB 1500-000	4800 Ω	Bus bar	
CAB 1500-001	4800 Ω	Panel mounting	
CAB 1500-005	4800 Ω	Bus bar	CAN ID 0x226

Special features

- Connector type: Tyco AMP 1473672-1
- Configurable CAN speed
- Configurable CAN ID.

Advantages

- Low offset
- Total error 0.5 % over temperature range: −40 °C to +85 °C
- · Full galvanic separation
- Compatible with 800 V applications following IEC60664-1 standard.

Automotive applications

The CAB 1500 Family is designed to run in a vehicle battery pack or in a battery disconnect unit and cannot be used in an environment exposed to water projections or gravel projections. The CAB-SF 1500 is compliant with Functional Safety standard ISO 26262

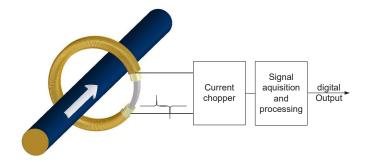
The test items used to validate the product are described at the end of the document.

Principle of Fluxgate Transducers

A low-frequency fluxgate transducer is made of a wound core which saturates under low induction.

A current chopper switches the winding's current to saturate the magnetic core alternatively at ±Bmax with a fixed frequency. Fluxgate transducers use the change of the saturation's point symmetry to measure the primary current.

Due to the principle of switching the current, all offsets (electric and magnetic) are cancelled.





Safety



If the device is used in a way that is not specified by the manufacturer, the protection provided by the device may be compromised. Always inspect the electronics unit and connecting cable before using this product and do not use it if damaged.

Mounting assembly shall guarantee the maximum primary conductor temperature, fulfill clearance and creepage distance, minimize electric and magnetic coupling, and unless otherwise specified can be mounted in any orientation.



Caution, risk of electrical shock

This transducer must be used in limited-energy secondary circuits SELV according to IEC 61010-1, in electric/electronic equipment with respect to applicable standards and safety requirements in accordance with the manufacturer's operating specifications.

Use caution during installation and use of this product; certain parts of the module can carry hazardous voltages and high currents (e.g. power supply, primary conductor).

Ignoring this warning can lead to injury and or/or cause serious damage.

This transducer is a build-in device, whose hazardous live parts must be inaccessible after installation.

This transducer must be mounted in a suitable end-enclosure.

Besides make sure to have a distance of minimum 30 mm between the primary terminals of the transducer and other neighboring components.

This transducer is a built-in device, not intended to be cleaned with any product. Nevertheless if the user must implement cleaning or washing process, validation of the cleaning program has to be done by himself.



ESD susceptibility

The product is susceptible to be damaged from an ESD event and the personnel should be grounded when handling it.

Do not dispose of this product as unsorted municipal waste. Contact a qualified recycler for disposal.

Although LEM applies utmost care to facilitate compliance of end products with applicable regulations during LEM product design, use of this part may need additional measures on the application side for compliance with regulations regarding EMC and protection against electric shock. Therefore LEM cannot be held liable for any potential hazards, damages, injuries or loss of life resulting from the use of this product.



Underwriters Laboratory Inc. recognized component



UL 508: Ratings and assumptions of certification

File # E189713 Volume: 2 Section: 12

Standards

- CSA C22.2 NO. 14-10 INDUSTRIAL CONTROL EQUIPMENT Edition 13
- UL 508 STANDARD FOR INDUSTRIAL CONTROL EQUIPMENT Edition 18

Ratings

Parameter	Symbol	Unit	Value
Primary involved potential		V AC/DC	600
Max surrounding air temperature	T_{A}	°C	85
Primary current	I_{P}	А	500
Secondary supply voltage	U_{C}	V DC	18
Output voltage	U_{out}	V	0 to 5

Conditions of acceptability

When installed in the end-use equipment, consideration shall be given to the following:

- 1 These products must be mounted in a suitable end-use enclosure.
- 2 The secondary circuit pin terminals have not been evaluated for field wiring.
- 3 Low voltage control circuit shall be supplied by an isolated source of supply.
- 4 These products shall be used in a pollution degree 2 environments or better.
- 5 Primary feeder of the devices shall be connected after an overvoltage device or system which has been evaluated by the Standard for Transient Voltage Surge Suppressors, UL 1449 with a maximum clamping voltage of 6 kV.

Marking

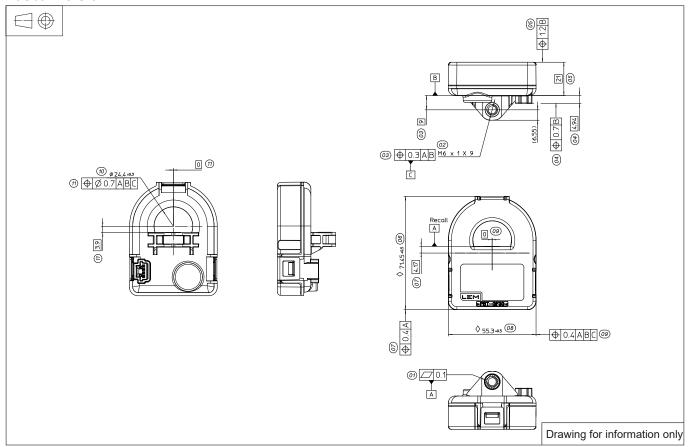
Only those products bearing the UR Mark should be considered to be Listed or Recognized and covered under UL's Follow-Up Service. Always look for the Mark on the product.



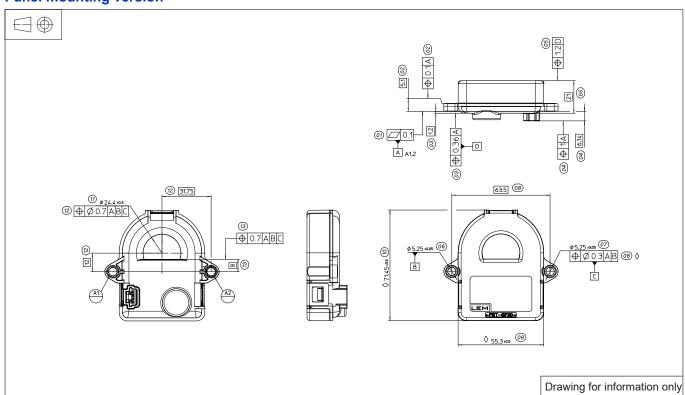


Dimensions (in mm. General geometrical tolerance 15; General linear tolerance ±0.5)

Busbar version



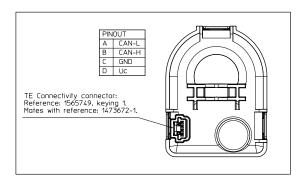
Panel mounting version



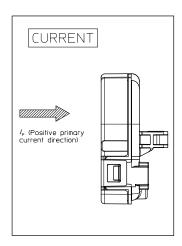




Connector pin out



Primary current direction as below:



Weight and Recommended screwing torque instruction

Busbar Version

- Weight: 94 g ±5 %
- Recommended screwing torque instruction:
 - transducer shall be fixed with M6 fastener
 - tightening torque:
 - screw grade 6.8: 6.6 N·m
 screw grade 8.8: 7.7 N·m

Panel mounting Version

- Weight: 91 g ±5 %
- Recommended screwing torque instruction:
 - transducer shall be fixed with 2 M5 fastener
 - tightening torque:
 - screw grade 6.8: 3.8 N·mscrew grade 8.8: 4.4 N·m

Laser Marking

Designation	Datacode	2D matrix content	Text marking area
CAB-SF 1500-000		PYYDDDCCHHMMSSJ90.D9.65.000.0	
CAB-SF 1500-001		PYYDDDCCHHMMSSJ90.D9.65.001.0	
CAB-SF 1500-004		PYYDDDCCHHMMSSJ90.D9.65.004.0	DESIGNATION
CAB-SF 1500-005		PYYDDDCCHHMMSSJ90.D9.65.005.0	PYYDDDCCHHMMSSJ
CAB-SF 1500-006	P = Production center ID YY = Last two digit of the year DDD = Day number of the year CC = Machine ID HH = Hour	PYYDDDCCHHMMSSJ90.D9.65.006.0	LEM PET-GF30-3
CAB-SF 1500-008		PYYDDDCCHHMMSSJ90.D9.65.008.0	
CAB-SF 1500-009	MM = Minute SS = Second	PYYDDDCCHHMMSSJ90.D9.65.009.0	
CAB-SF 1500-011	∃ J = Machine jig ID	PYYDDDCCHHMMSSJ90.D9.65.011.0	
CAB 1500-000		PYYDDDCCHHMMSSJ90.H5.65.000.0	
CAB 1500-001		PYYDDDCCHHMMSSJ90.H5.65.001.0	
CAB 1500-005	-	PYYDDDCCHHMMSSJ90.H5.65.005.0	





Absolute ratings (not operating)

Parameter	Symbol	Unit	Specification	Conditions
Over-voltage	U_{C}	V	24	1 min
Reverse polarity	U_{c}	V	-18	1 min
Minimum supply voltage	$U_{ m Cmin}$	V	6	continuous
Maximum supply voltage	$U_{\mathrm{C}\mathrm{max}}$	V	18	continuous
Ambient storage temperature	T_{Ast}	°C	-40 /+105	
Creepage distance	d_{Cp}	mm	12.5	_
Clearance	d_{CI}	mm	12.5	
RMS voltage for AC insulation test	U_{d}	kV	3.5	50 Hz,1 min
Insulation resistance	R_{INS}	ΜΩ	500	1000 V - ISO 16750-2
IP Level			IP41	

Characteristics in nominal range

Dawareatan	Complete	1114	Specification		on	Operatistance	
Parameter	Symbol	Unit	Min	Typical	Max	Conditions	
		EI	ectrical D	ata			
Supply voltage	17	V	9	13.5	16	-1500 A ≤ I _p ≤ 1500 A	
Supply voltage	U_{c}	v	8	13.5	16	$-1000 \text{ A} \le I_{p} \le 1000 \text{ A}$	
RMS current consumption @ I_p = 0 A ¹⁾	I_{C}	mA	50	70	100	8 V < $U_{\rm C}$ < 16 V, CAN acknowledge	
RMS current consumption @ $\pm I_p$ = 1000 A ¹⁾	I_{C}	mA	350	400	1000	8 V < $U_{\rm C}$ < 16 V, CAN acknowledge	
RMS current consumption @ $\pm I_p$ = 1500 A ¹⁾	I_{C}	mA	430	500	1400	9 V < $U_{\rm C}$ < 16 V, CAN acknowledge	
Ambient operating temperature	T_{A}	°C	-40		+85		
		Per	formance	Data			
Primary nominal DC current	I_{PN}	Α	-1500		1500		
CAN signal 'CSM_BAT_CURRENT' clamping value		А	-1550		1550	1550 A $<$ $ I_{\rm P} $ $<$ $\hat{I}_{\rm P max}$	
Primary withstand peak current (maximum)	\hat{I}_{Pmax}	Α		1700			
Overload recovery time	t _s	ms		10		When $I_{\rm p}$ goes back under 1550 A	
Frequency bandwidth	BW	Hz		20		With Periodic CAN message @ 10 ms	
Start-up time	t _{start}	ms		150		Times after enabled timer/fluxgate, excluded 20 ms additional times for HW initialization/ check	
	-	Analog m	easureme	ent Channe	el		
Linearity error	ε_{L}	%		±0.1		At room temperature	
Total error: [-1500 A, +1500 A]	$arepsilon_{ ext{tot}}$	%		±0.5		Over full temperature range Performances are considered with average value over 20 CAN frames (200 ms); Performances with average value over 10 CAN frames (100 ms), refer to Application Notes	
Output noise		mA		±50		With Periodic CAN message @ 10 ms. Peak to peak value. No averaging	
		Digital mo	easureme	nt channe	I		
Total error	$arepsilon_{ ext{tot}}$	%		±7		With a minimum of ±2 A Typical value after ageing Performances are considered with average value over 20 CAN frames (200 ms)	

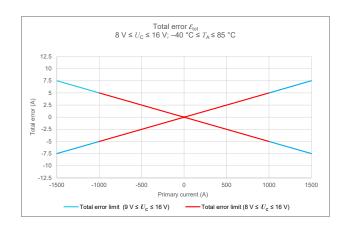
Note: 1) Input current peak value refer to Application Notes .

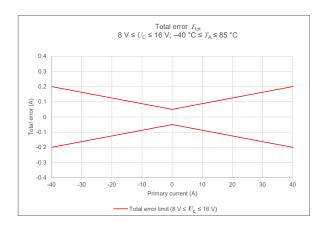




Total error

Analog Channel - Total error from −40 °C to 85 °C: Performances are considered with average value over 20 CAN frames (200 ms)





I_{p}	Total error (9 V $\leq U_{\rm c} \leq$ 16 V ; $-$ 40 °C $\leq T_{\rm A} \leq$ 85 °C)					
(A)	(A)	(%)				
-1500	±7.5	±0.5				
-40	±0.2	±0.5				
0	±0.05	-				
40	±0.2	±0.5				
1500	±7.5	±0.5				

I_{p}	Total error (8 V ≤ <i>U</i> _c ≤ 16 V ; −40 °C ≤ <i>T</i> _A ≤ 85 °C)					
(A)	(A)	(%)				
-1000	±5	±0.5				
-40	±0.2	±0.5				
0	±0.05	-				
40	±0.2	±0.5				
1000	±5	±0.5				





External Magnetic Field Influences

The CAB 1500 Family delivers accurate current measurement. However, to ensure its proper functioning and to ensure the current measurement accuracy, it is necessary to comply with rules for setting up in the BMS environment. Thus, some conditions must be respected during the design of the environment of the transducer:

- · Primary busbar centering
- · Busbar shape
- · Contactors position

LEM's recommendations can be found in the application notes available on request. Please contact LEM support team to ensure that your busbars design fits with LEM's design guideline.

Current Ripple Influences

Current ripples on the high voltage DC lines could be induced during power conversion from devices like DC/DC, inverter, on-board charger, and so on.

Current ripples not only negatively impact on the health of li-ion batteries, but also could cause malfunctions of the CAB transducer. The failure mode can manifest itself as a disturbed current measurement due to aliasing effect, leading to internal error when the threshold is exceeded. The malfunctions can be automatically recovered when the ripple current disappears.

Normally the ripple current should be measured and minimized during vehicle system design and development. For proper function of the CAB transducer, the acceptable maximum value of the ripple current should be checked. Please contact LEM support team on the reference values, LEM's recommendations can be found in the application notes available on request.





CAN output specification

- CAN protocol 2.0B
- Bit order: big endian (Motorola)
- CAN oscillator tolerance: 0.27 %
- No sleep mode capability
- 120 Ohm termination resistor to be added externally (except CAB-SF 1500-006), internal CAN impedance = 4.8 kOhm
- CAB-SF 1500-006 integrates 120 Ohm termination resistor inside transducer
- Instruction for CAN modification can be found in the application notes available on request

CAB-SF 1500 CAN message table

CAB1500_I_p message overview.
 Default frame ID: 0x3C2; transmit period: 10 ms.

CAN Frame Content										
	7	6	5	4	3	2	1	0		
BYTE 0		Sequence Counter $I_{\rm p}$				werSupply	StatusInternalError	SafetyGoalViolation		
	MSB			LSB	MSB	LSB				
BYTE 1	Analog Current									
DITE	MSB									
BYTE 2					Analog (Current				
BYTE 3	Analog Current									
								LSB		
BYTE 4	Digital Curent									
	MSB									
BYTE 5	Digital Curent									
								LSB		
BYTE 6					Rese	rved				
	MSB							LSB		
BYTE 7					CRC	$_{P}I_{P}$				
DITE	MSB							LSB		





• 'Sequence Counter I_P' signal

- · Initialized with 0 and incremented by 1 for every subsequent send request
- When the counter reaches the value 15 (0xF), then restart with 1 for the next send request.

• 'Status Power Supply' signal

CAN Frame Content										
	7	6	5	4	3	2	1	0		
BYTE 0	SequenceCounterI _p				StatusPov	werSupply	StatusInternalError	SafetyGoalViolation		
	MSB			LSB	MSB	LSB				

When Power Supply voltage measurement is not available, then 'Status Power Supply' = "1 1"

Notes

- At transducer start-up, if supply voltage < 7.8 V or > 16.2 V, no CAN frame emission
- Status details can be found in the application notes available on request.

· 'Status Internal Error' signal

This flag is set to 1 to inform the BMS about two scenarios:

- · Internal hardware abnormal detected (reference voltage, DAC errors and impact from application ripple current, etc)
- Over current detected on the busbar current above 1600 A. In this use case, the Status Internal Error flag is set to 1 (see details on the next page in 'Analog Current' signal section)

• 'Safety Goal Violation' signal [SG1: Current Sensing Error]

In the current range of [-1500 A; -220 A [and] +220 A; +1500 A], if there is more than 20% of difference between analog current level and digital current level --> then Safety Goal Violation = 1

In the current range of [-220 A; 220 A], if there is a gap above 44 A between analog current level and digital current level --> then Safety Goal Violation = 1

Safe State: To provide Safety Goal Violation flag, keep providing current measurement FTTI: 500 ms





• 'Analog Current' signal

Analog measurement of the primary current

 $-1500 \le I_p \le +1500$. 'Analog Current' signal = I_p . Error = 0.5 %

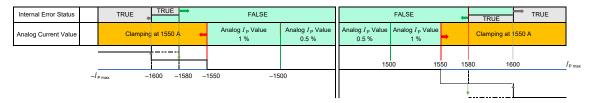
1500 < $|I_P| \le$ 1550. 'Analog Current' signal = I_P . Error = 1 %

 $-\hat{I}_{\rm P\,max} \leq I_{\rm P} < -1550$. 'Analog Current' signal is clamped at -1550 A.

+1550 < $I_{\rm P} \le \hat{I}_{\rm P\,max}$. 'Analog Current' signal is clamped at +1550 A.

 $|I_{\rm p}| > \hat{I}_{\rm p\,max}$. 'Analog Current' signal = 0xFFFFFF.

Note: $\hat{I}_{P \text{ max}} \approx 1700 \text{ A}$



Here below the values for Byte 1, 2 and 3:

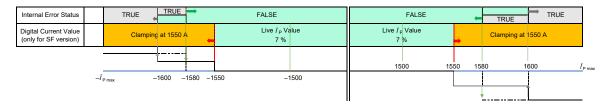
$I_{\mathtt{P}}$	Hex value	MSB		LSB
		Byte 1	Byte 2	Byte 3
1550.000	97A6B0	97	A6	В0
1500.000	96E360	96	E3	60
0.001	800001	80	00	01
0.000	800000	80	00	00
-0.001	7FFFF	7F	FF	FF
-1500.000	691CA0	69	1C	A0
-1550.000	685950	68	59	50





• 'Digital Current' signal

 $-\hat{I}_{\rm P\,max} \le I_{\rm P} < -1550$. 'Digital Current' signal is clamped at -1550 A. Error = NA $+1550 < I_{\rm P} \le \hat{I}_{\rm P\,max}$. 'Digital Current' signal is clamped at +1550 A. Error = NA



Digital measurement of the primary current, Byte 4 and 5:

$I_{\mathtt{p}}$	Hex value	MSB	LSB
		Byte 4	Byte 5
1550	860E	86	0E
1500	500 85DC 85		DC
1	8001	80	01
0	8000	80	00
-1	7FFF	7F	FF
-1500	7A24	7A	24
-1550	79F2	79	F2

• 'CRC $_I_P$ ' signal

8-bit SAE J1850 CRC calculation of the first seven bytes.



CAB 1500 CAN message table

• CAB1500_I_P message overview.

Default frame ID: 0x3C2; transmit period: 10 ms.

	CAN Frame Content										
	7	6	5	4	3	2	1	0			
BYTE 0	Sequence Counter $I_{_{\rm P}}$				StatusPov	werSupply	StatusInternalError	Reserved			
	MSB			LSB	MSB	LSB					
BYTE 1				Anal	og Curren	ıt					
DIICI	MSB										
BYTE 2		Analog Current									
DITE 2											
BYTE 3	Analog Current										
								LSB			
BYTE 4	Reserved										
DITE 4											
BYTE 5	Reserved										
BYTE 6				R	eserved						
BYTE 7				C	RC_I_P						
םוובו	MSB							LSB			

• 'Sequence Counter I_P ' signal

- Initialized with 0 and incremented by 1 for every subsequent send request
- When the counter reaches the value 15 (0xF), then restart with 1 for the next send request

• 'Status Power Supply' signal

CAN Frame Content								
	7	6	5	4	3	2	1	0
BYTE 0	Sequence Counter I _P			StatusPowerSupply		StatusInternalError	Reserved	
	MSB			LSB	MSB	LSB		

When Power Supply voltage measurement is not available, then 'Status Power Supply' = "1 1"

Notes:

- \bullet At transducer start-up, if supply voltage < 7.8 V or > 16.2 V, no CAN frame emission
- Status details can be found in the application notes available on request.





• 'Status Internal Error' signal

This flag is set to 1 to inform the BMS about two scenarios:

- Internal hardware abnormal detected (reference voltage, DAC errors and impact from application ripple current, etc)
- Over current detected on the busbar current above 1600 A. In this use case, the Status Internal Error flag is set to 1 (see details on the next page in 'Analog Current' signal section)

• 'Analog Current' signal

Analog measurement of the primary current

 $-1500 \le I_P$ ≤ +1500. 'Analog Current' signal = I_P . Error = 0.5 %

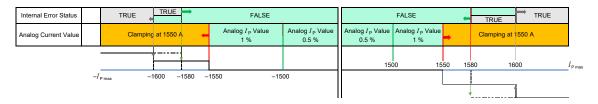
1500 < $|I_p| \le$ 1550. 'Analog Current' signal = I_p . Error = 1 %

 $-\hat{I}_{P,max} \le I_P < -1550$. 'Analog Current' signal is clamped at -1550 A.

+1550 < $I_{\rm P} \le \hat{I}_{\rm P\,max}$. 'Analog Current' signal is clamped at +1550 A.

 $|I_{\rm p}| > |\hat{I}_{\rm P\,max}|$. 'Analog Current' signal = 0xFFFFFF.

Note: $|\hat{I}_{P \text{ max}}| \approx 1700 \text{ A}$



Here below the values for Byte 1, 2 and 3:

I_{P}	Hex value	MSB		LSB
		Byte 1	Byte 2	Byte 3
1550.000	97A6B0	97	A6	В0
1500.000	96E360	96	E3	60
0.001	800001	80	00	01
0.000	800000	80	00	00
-0.001	7FFFF	7F	FF	FF
-1500.000	691CA0	69	1C	A0
-1550.000	685950	68	59	50

'CRC_I_D' signal

8-bit SAE J1850 CRC calculation of the first seven bytes.





Applicable standards - Functional Safety - CAB-SF 1500

		Safety
		Safety Manual Table of Contents
Functional Safety	ISO 26262	1 DOCUMENT
(ASIL C compliant)	(11/2018)	1.1 Applicable documents
(MOIL O compliant)	(11/2010)	1.2 Reference documents
		2 GLOSSARY
		3 Introduction
		4 Assumption
		5 Product overview
		5.1 Purpose
		5.2 Type of Current Transducer
		5.3 Safety Element out of Context (SEooC)
		5.4 Functional Block Diagram
		5.5 Mission Profile
		6 Safety Measures
		6.1 Safety Goal allocated to the transducer
		6.2 Safety Concept
		6.3 Description of the maintenance activities expected from the customer
		6.4 Description of the maintenance activities expected from the customer in the case of a failure indicated by the warning and degradation concept
		7 Hardware Requirements on System Level
		7.1 Datasheet Compliance
		8 Software Requirements on System Level
		8.1 DTC Monitoring
		9 Failure Rates and FMEDA
		9.1 FMEDA Reference Document
		9.2 FMEDA Applicable Standard
		9.3 Failure Mode Distribution
		9.4 FMEDA Results
		10 Provisions Against Dependent Failures
		10.1 External Parasitic Magnetic Fields
		10.2 Environmental constraints
		11 Measures to Prevent Systematic Failures
		11.1 Parasitic Magnetic Fields due to Bus Bar design
		11.2 Current Ripple Influences
		11.3 CAB-SF 1500-C Fastening
		12 Diagnostic
		12.1 Diagnostic Trouble Codes Monitoring
		12.2 Diagnostic Mode / Maintenance Operation
		13 Safety-related content of the instructions for operation, service and decommissioning
		14 Field Monitoring

^{*}Safety Manual availability after NDA and assurance of business signed.





Applicable standards - PV tests performed - CAB-SF 1500

Test	Standard	Procedure	
CHARACTERIZATION AT 25 °C (Initial and final)	LEM CO.60.09.014.0	Sensitivity; Total error; Offset; Linearity error; Current Consumption	
CHARACTERIZATION IN TEMPERATURE RANGE (Initial and final)	LEM CO.60.09.014.0	Sensitivity; Total error; Offset; Linearity error; Current Consumption	
	Environmenta	I test	
Ageing 85 °C /85 % <i>RH</i>	JESD 22-A101 (03/2009)	T °C = 85 °C; RH = 85 %; Duration = 1000 h Transducer not supply Check After stab. @ 25 °C (End test) Performance after test, from -40 °C to 85 °C: $I_{\rm O} \le$ 50 mA, $\varepsilon_{\rm tot} \le$ 1 %	
Low temperature storage	ISO 16750-4 § 5.1.1.2 (04/2010)	$T ^{\circ}\text{C} = -40 ^{\circ}\text{C}$ Duration = 24 h; Power off, no monitoring Check After stab. @ 25 $^{\circ}\text{C}$ (End test)	
High temperature storage	ISO 16750-4 § 5.1.2.2 (04/2010)	T °C = 85 °C Duration = 96 h; Power off, no monitoring Check After stab. @ 25 °C (End test)	
Temperature cycle with specified change rate	ISO 16750-4 § 5.3.1 (04/2010)	T °C = -40 °C & +85 °C, see Fig. 2 of ISO 16750-4 Duration = 30 cycles; 1 cycle = 8 h Total duration = 10 days $U_{\rm C}$ = 13.5 V (\equiv connected); $I_{\rm p}$ = 0 A; no monitoring Check After stab. @ 25 °C (End test)	
Thermal shock	ISO 16750-4 § 5.3.2 (04/2010)	T °C = " T °C Operating min & max" −40 to +85 °C Duration = 300 cycles according to the climatic code (defined table 4); Exposure time : 30 min. $U_{\rm C}$ = NO power supply (\equiv unconnected) and No wiring harness Check After stab. @ 25 °C (End test)	
Random Vibration	ISO 16750-3 § 4.1.2.4 (12/2012)	Random; -40 °C /+85 °C during 8 hours; 8 h for each axie and each DUT; RMS acceleration 27.1 m/s² Torque measurement before and after. Connected but not supply. No monitoring	
Mechanical Shocks	ISO 16750-3 § 4.2 (12/2012)	Temperature: Ambient temperature. Default § 4.2.2 Operating mode: 3.2 Pulse shape: half sine, 50 G, 6 ms 10 shocks per direction (total 60) & Meas. torque Bef. and After Offset before and after; Parts not connected Check After stab. @ 25 °C (End test)	
Free Fall	ISO 16750-3 § 4.3 (12/2012)	Number of devices: 3 Falls/DUT: 2 Height = 1 m on Concrete floor 3 axes; 2 directions by axis; 1 sample by axis Operating mode: 1.1 Temperature: 25 °C if not specified Check after test at 25 °C and visual inspection	
Cross section checking on PCBA	IPC-A-610G: 2017 Class 3	IPC-TM-650 2.1.1F:2015	
Cross section checking on solderless connections	GB/T 18290.5-2015	IPC-TM-650 2.1.1F:2015	
Whisker checking on PCBA	Refer to JESD201-A (04/2010)	Refer to JESD22-A121A (04/2010) Class 2	



CAB 1500 series

Test	Standard	Procedure	
	Electrical to	est	
Reversed voltage	ISO 16750-2 § 4.7 (12/2012)	Test performed at room temperature By default: case 2; Duration : 60 s; Level defined in table 7 according to the nominal system voltage	
Overvoltage (for 12 V nominal voltage)	ISO 16750-2 § 4.3.1 (12/2012)	T °C = $T_{\rm max}$ - 20 °C and room temperature; At $T_{\rm max}$, apply 18 V for 60 min to all inputs; At room temperature, apply 24 V for 60 s	
Superimposed alternating voltage	ISO 16750-2 § 4.4 (12/2012)	12 V system severity1: 1 V peak to peak according to Fig. 2 triangular, logaritymic 5 times sweep continuously	
Slow decrease and increase of supply voltage	ISO 16750-2 § 4.5 (12/2012)	Test performed at room temperature $U_{\rm Smin}$ = 8.5 V Decrease from $U_{\rm Smin}$ to 0 V and increase from 0 V to $U_{\rm Smin}$; Change rate: 0.5 V/min > 8.5 V < 8.5 V	
Momentary drop in supply voltage	ISO 16750-2 § 4.6.1 (12/2012)	Test performed at room temperature $U_{\rm C\ min}$ = 8.5 V $U_{\rm C\ min}$ to 4.5 V See Fig. 4	
Reset behavior at voltage drop	ISO 16750-2 § 4.6.2 (12/2012)	Test performed at room temperature See Fig. 6	
Load dump	ISO 16750-2 § 4.6.4 (12/2012)	Test performed at room temperature Pulse B, Pulse described in table 6 'System with 12 V nominal voltage Class C $U_{\rm A}$ = 14 V, $U_{\rm S}$ * = 35 V, $U_{\rm S}$ = 80 V, $R_{\rm i}$ = 1 Ohm $T_{\rm d}$ = 400 ms, 5 pulses at 1 min intervals See Fig. 9	
Ground reference and supply offset	ISO 16750-2 § 4.8 (12/2012)	Test performed at room temperature and test method defined at § 4.8.2	
Open circuit test - single line interruption	ISO 16750-2 § 4.9.1 (12/2012)	Operating the transducer and open the circuit line after line. Opening duration for each line: 10 s	
Short circuit protection - signals circuits	ISO 16750-2 § 4.10.2 (12/2012)	Connect all inputs and outputs to $U_{\rm S\;max}$ = 16 V and to GND for a duration of 60 s	
Withstand voltage	ISO 16750-2 § 4.11 (12/2012)	3.5 KV AC 50 Hz 60 s	
Insulation resistance	ISO 16750-2 § 4.12 (12/2012)	1000 V DC for 60 s Resistance criteria: > 1000 MOhm	



CAB 1500 series

Test	Standard	Procedure	
	EMC test		
Resistance to electrostatic discharges (handling device)	ISO 10605 (07/2008)	Contact discharges: ± 8 kV; Air discharges: ± 15 kV. $U_{\rm C}=$ NO power supply (\equiv unconnected)	
Immunity to Radiated field- Anechoic chamber(ALSE with ground plane)	ISO 11452-2 (11/2019)	Test level II and Test level IV CW and AM in the [200 MHz – 800 MHz] frequency band. CW, AM and PM1 in the [800 MHz – 1 GHz] frequency band. CW and PM1 in the [1 GHz – 1.2 GHz] frequency band. CW and PM2 in the [1.2 GHz – 1.4 GHz] frequency band. CW and PM1 in the [1.4 GHz – 2.7 GHz] frequency band. CW and PM2 in the [2.7 GHz – 3.2 GHz] frequency band.	
Transient Disturbances Conducted along Supply Lines	ISO 7637-2 (03/2011)	test pulse : 1 : -100 V t_1 = 5 s (0.2 to 5 s) 2a : 50 V t_1 = 0.2 to 5 s 2b : 10 V t_d = 2 s 3a : U -150 V 3b : U 100 V	
Transient Disturbances Conducted along I/O or Transducer Lines	ISO 7637-3 (07/2016)	12 V nominal supply voltage Fast a: CCC –150 V 10 min Fast b: CCC +100 V 10 min slow pulse positive: ICC +20 V 20 min slow pulse negative: ICC –20 V 20 min	
Immunity to Bulk Current Injection (BCI)	ISO 11452-4 (12/2011)	Table E.1 Test level I, 1 MHz to 3 MHz : 60 mA * F(MHz) /3 3 to 400 MHz : 60 mA Test level II, 1 MHz to 3 MHz : 100 mA * F(MHz) /3 3 to 400 MHz : 100 mA Test level IV, 1 MHz to 3 MHz : 200 mA * F(MHz) /3 3 to 400 MHz : 200 mA	
Conducted emission - Voltage method	CISPR 25 (2016) § 6.3	Table 5, Class 3, BROADCAST and MOBILE SERVICES f = 0.15 MHz to 108 MHz	
Radiated emission - ALSE	CISPR 25 (2016) § 6.5	Table 7, Class 3, BROADCAST and MOBILE SERVICES	
Immunity to magnetic fileds	ISO 11452-8 (2015)	12 V Nominal supply voltage radiating loop method Test requirement see TableA.1(Internal filed) Test level I FPSC Status I	





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